



Technical Report
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Single Crystal Diffraction at ISIS

User Guide for the SXD Instrument

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October 1996

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Single Crystal Diffraction at ISIS

User Guide for the SXD Instrument

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1. Introduction

This guide is intended to give a short description of the SXD single crystal diffractometer and to provide the basic information required to perform a single crystal diffraction experiment. It will be divided into three sections, covering an introduction to the instrument and ISIS, performing an experiment on SXD and preliminary data assessment (including crystal alignment). Two appendices are available separately, one concerned with Bragg intensity extraction and structural refinement and the other with diffuse scattering data analysis, together with absolute normalisation of diffuse scattering data.

1.1 Overview

The SXD diffractometer at ISIS operates as a general purpose single crystal diffractometer, using the time-of-flight Laue technique. The utilisation of both the time-of-flight technique to sort the white beam and large area position-sensitive detectors (p.s.d.'s) makes it possible to access large volumes of reciprocal space in a single measurement. Experiments which exploit the large continuous coverage of volumes of reciprocal space are most ideally suited to the instrument. These include diffuse scattering studies where the features of interest are broad and often in unexpected regions of reciprocal space. This diffuse scattering may result from thermally induced disorder (e.g. TDS), or from local static distortions from crystalline disorder (e.g. defects in fluorites). Measurements on magnetic materials which show satellite peaks can be readily accommodated on SXD, as can studies of phase transitions, since prior knowledge of where to expect scattering to occur is not necessary. Standard crystallographic refinements are of course also possible, and use can be made of the epithermal, short wavelength neutrons that are available on a pulsed source to allow measurements to very high resolution (high $\sin\theta/\lambda$).

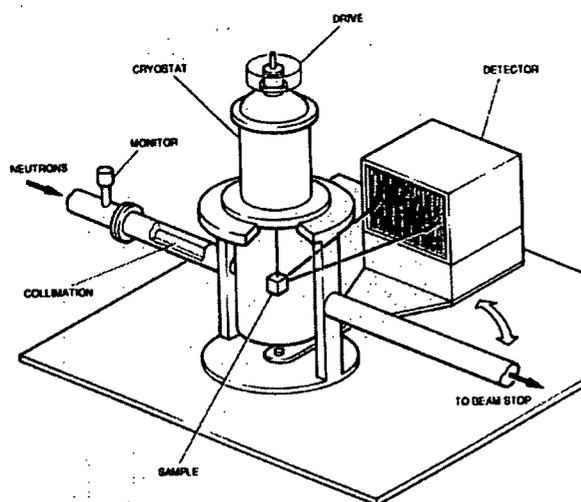


Figure 1 *SXD layout*

The general design of the instrument is shown, with the wavelength sorted (by the time-of-flight technique, see section 4.1) white neutron beam arriving from the moderator, incident on the sample, which is often contained in sample environment kit. The scattered neutrons are detected in one or more two dimensional position-sensitive detectors (PSDs). The combination of the PSD and tof sorting yields data frames containing full three-dimensional reciprocal space volumes.

1.2 Instrument Design

The SXD single crystal diffractometer (Figure 1) is situated on beam line S3 at ISIS (Figure 2). It receives neutrons from a 316K H₂O moderator, poisoned with Gd at a depth of 2.0 cm, to improve the neutron peak shape. The overall moderator to sample distance is 8.0 m and the beam size at the sample is a maximum of 15mm in diameter, with various beam sizes able to be defined using B₄C inserts in the collimation box immediately before the sample (Figure 3).

Figure 2 Instrument layout and view from the SXD cabin

(below right) SXD is located in the South West corner of the ISIS Experimental Hall (R55), on beamline S3. The view shows the Target Station, with the POLARIS instrument blockhouse in the centre and the KARMEN neutrino experiment on the right. SXD is located roughly between the two. (below) Layout

of the ISIS Experimental Hall, showing the neutron and muon instruments. SXD is situated on beamline S3, at the top right of this plan. The ISIS entrance Foyer and Main Control Room are at the bottom left in this plan.

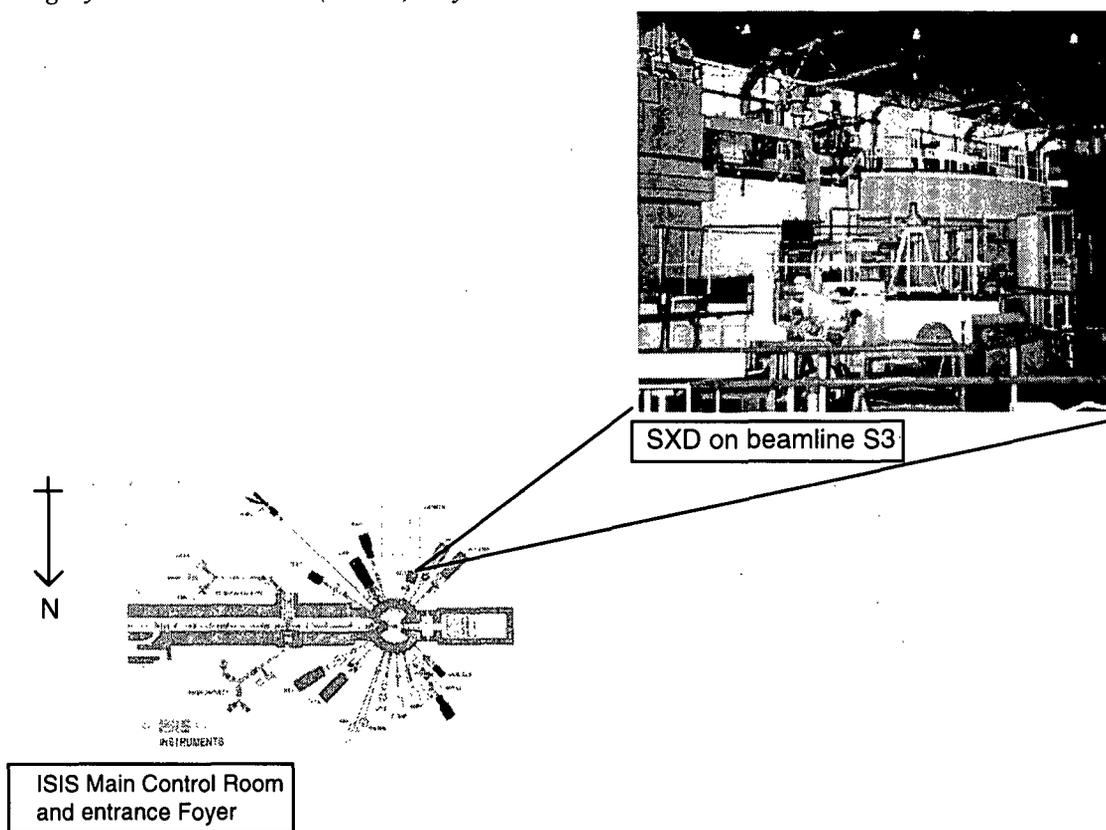
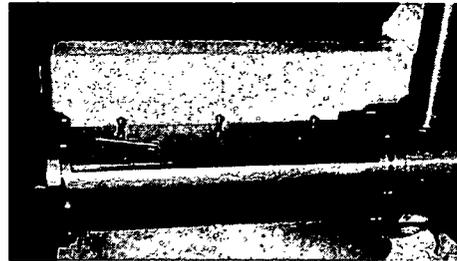
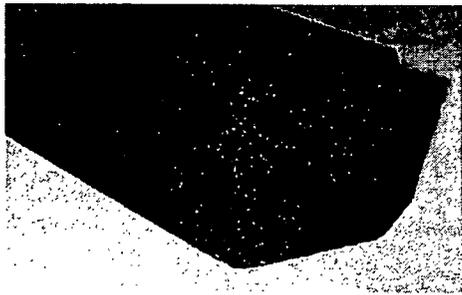


Figure 3 Collimation Box and Collimators

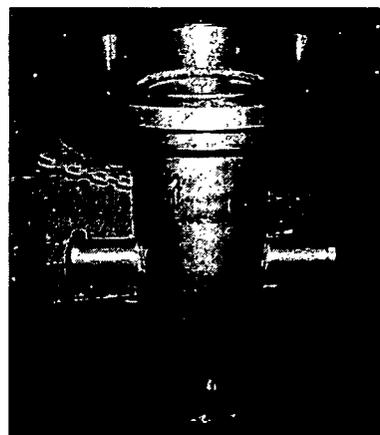
The beam diameter on SXD is defined using B₄C 'crispy-mix' collimators with various diameter apertures. One of these is shown below, while on the right are shown the vacuum box in the beam line containing the collimation (top), and with its shielding installed (bottom).



There are two sample tanks, one with 100 mm outer radius (Figure 4) and the other with 240 mm, but the latter is rarely used at present. Motor drives compatible with these tanks provide for ω -rotation of the sample. These tanks are normally evacuated to a nominal 10^{-5} torr using the instrument turbo pump, mounted downstream of the sample position, although for much of the sample environment equipment these tanks must be removed (see section 1.5).

Figure 4 Vacuum Tank

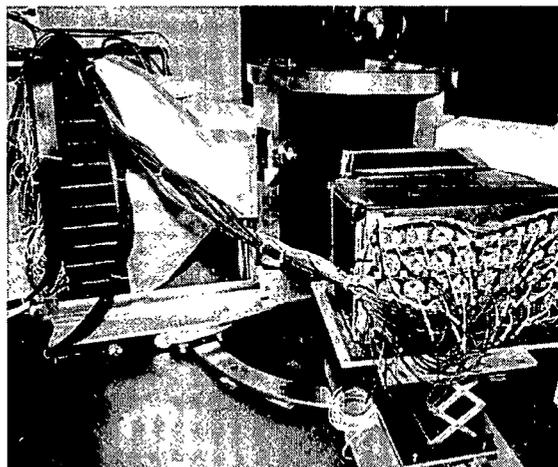
The 100 mm radius vacuum tank, with the incoming and outgoing beam pipes. When installed, this tank forms an integral part of the beamline vacuum. In addition to ambient experiments, the ω -rotation CCR can be installed in this apparatus.



The area position-sensitive detectors (see section 1.3) are mounted on arms which allow limited γ -rotation (varying 2θ for the centre of the detector between 50° and 90° for the low angle arm and 90° and 130° for the high angle arm) and also manual adjustment of L_2 , the sample to detector distance (Figure 5). This varies in the range $70 < L_2 < 500$ mm, dependent on sample environment equipment and detector. There is also the possibility for the future installation of a set of oscillating radial collimators between the sample tank and detector. In preliminary tests these were found to reduce unwanted scattering from complex sample environment such as pressure cells. These collimators consist of 48 Gd_2O_3 coated melinex foils between 128 mm and 242 mm from the sample and 200 mm high, with an angular separation of $\sim 1^\circ$, designed to define a 10 mm 'visible' portion of the incoming beam at the sample.

Figure 5 Double Detector Arrangement

View inside the SXD blockhouse, showing the yoke used for supporting sample environment equipment, along with the typical set-up with two detectors at low (left) and high (right) angles. In this view the neutrons arrive from the right.



1.3 Detectors

The development of detectors on SXD has been an evolutionary process, the detector being the critical component determining whether such an instrument is successful or not. A detector for SXD has to have a large active area to reduce overall counting times, but also it must be capable of counting quickly, with short dead-times to cope with the locally intense single crystal Bragg peaks. The polychromatic nature of the incident beam allows many Bragg reflections (>1000 in some cases) to diffract simultaneously into a typical $200 \times 200 \text{ mm}^2$ active area during an ISIS pulse. Therefore good pixel resolution, a fast count rate, linearity of response and stability are all required for a large area PSD.

Previously an Anger camera was installed, and subsequently an ORDELA gas PSD. Currently, ZnS scintillator PSDs are used on the instrument. The first of these, installed on the instrument in 1989, was built as a prototype to develop the concepts of fibre-optic

encoded ZnS PSDs. It consists of a square array of 256 $5 \times 5 \text{ mm}^2$ pixel elements arranged on a ceramic grid, fibre-optic encoded to a set of 32 photomultiplier tubes. The scintillator, a single, continuous piece of $\sim 0.4 \text{ mm}$ thick ^6Li -doped ZnS plastic, is supported just above the pixels, providing an active area of some $80 \times 80 \text{ mm}^2$. It is robust, linear to 0.1 mm , quiet, has a deadtime of $2\text{-}3 \mu\text{s}$ and a smooth, stable response. It has the added advantage that with a judicious choice of discriminator level it can be rendered virtually insensitive to γ rays.

The current detectors (Figure 6) represent a development of the first, consisting of a square array of 4096 $3 \times 3 \text{ mm}^2$ pixel elements, with only a thin Gd_2O_3 coated metal grid separating the four optic fibres required for each pixel from its neighbours. It has very similar characteristics to the prototype detector, but with the advantages of a smaller pixel size and, by utilising four-way coincidence, requires a mere 32 photomultiplier tubes for 4096 pixels. The total active area is $192 \times 192 \text{ mm}^2$. A second of these detectors was installed on the instrument in the early 1995, effectively doubling the count rate.

Figure 6 SXD Detector construction

The fibre-optic encoding used in the SXD detectors are shown in this view. The 64×64 pixel grid is encoded by 16384 optical fibres onto 32 photomultiplier tubes (not shown).

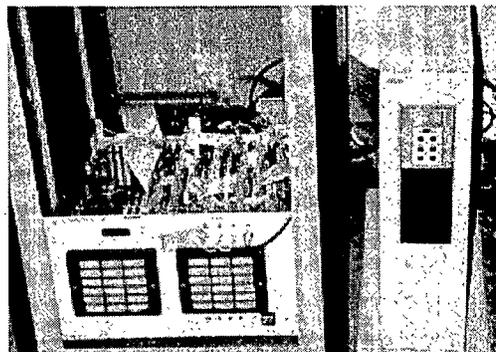


1.4 Data Acquisition

The SXD instrument control and data acquisition are performed by a VAX Workstation 3600. This computer, known as the Front End Minicomputer (FEM), is situated in the control cabin adjacent to the main SXD user cabin (Figure 7). The nodename of this machine is SXD, and the standard username for experimental control is also SXD. Your local contact will advise of the current password. This computer is the only one which can be used for control of the experiment and data acquisition.

Figure 7 Computer and Data Acquisition Electronics

Situated in the cabin adjacent to the main control cabin, the VAX 3600 is shown on the right of this picture, with the Data Acquisition Electronics System Crate on the left.



The current instrument settings are contained in a file called the Current Run Parameter Table (CRPT) and whilst the run is in progress the data are temporarily stored in the Data Acquisition Electronics (DAE). At the end of the run the contents of the CRPT and DAE are automatically written into a data file on the FEM and shortly afterwards this file is copied onto the archive system's optical disk. The FEM has a limited amount of disk storage space, and SXD data files tend to be large (~16000 VAX blocks even in compressed form), so data files are often deleted or moved to the SXD storage disk (SXD\$DISK1) soon after the end of each experiment. If deleted, they can easily be restored from the optical disk to the FEM for analysis of the data at a later date (see section 2.16). All the instrument FEMs and the central VAX computer (known as ISISE) are connected via an ETHERNET link to form a cluster, allowing each computer direct access to the disk storage area of any other computer on the cluster. Users logged on to ISISE can thus access data files stored on the FEM, but the CRPT and DAE can only be accessed from the FEM. SXD also has a DEC alpha workstation (nodename SXDA) for faster data manipulation, which will eventually supersede the VAX 3600 as the FEM.

1.5 Available Sample Environment Equipment

Although standard ISIS sample environment (SE) equipment can be accommodated on SXD, the special requirements of the instrument means that SE equipment tends to be peculiar to the instrument. This is because of the need to rotate single crystal samples, and to minimise background scattering in a large area PSD which cannot easily be shielded. The following are available:

- The standard sample vacuum tanks, providing ω -rotation at ambient temperatures;
- A liquid helium 50 mm bore 'Orange' cryostat (1.5-300 K). The tails have been adapted to provide reliable ω -motion and minimise unwanted scattering (Figure 8). Samples up to 35 mm in diameter can be accommodated.
- A standard RAL vanadium element furnace (293-1200 K), in which a sample centre-stick provides ω -rotation. Samples up to 35mm in diameter can be accommodated.
- A two circle orienter (χ - ϕ rotations; Figure 9) including a Displex cooler (12-300 K). Maximum sample size of about 10 mm on a side.

- A standard RAL CCR with ω -rotation (10-300 K). This fits inside the SXD vacuum tank giving very low background scattering.
- A high pressure He gas cell (<6 kbar) and McWhan cell (<25 kbar), which both fit inside a 100 mm bore 'Orange' cryostat. Both cells have a 6mm internal diameter and *manual* ω -rotation.
- A dilution fridge insert for cryostat for temperatures down to ~40 mK. *Manual* ω -rotation only.

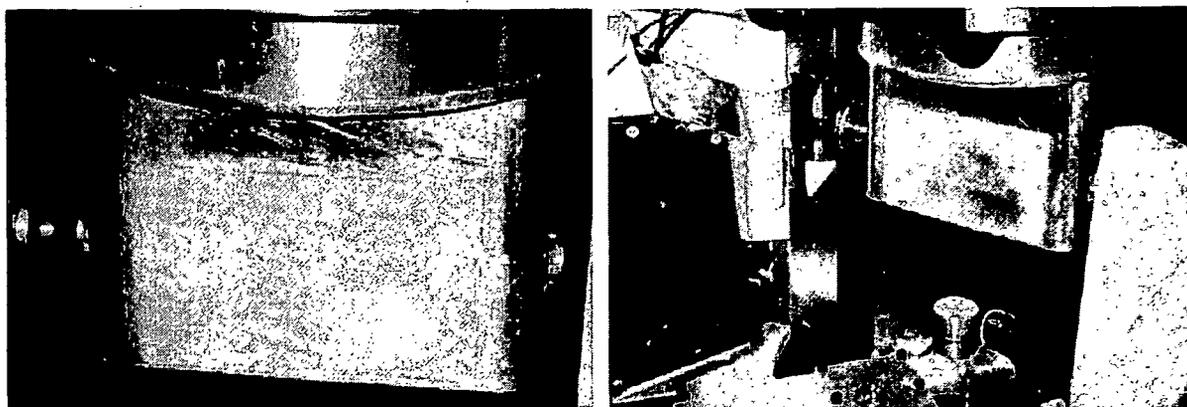


Figure 8 SXD Cryostat

(left) The design of the SXD cryostat tails allow for a short sample-detector distance. (right) The cryostat installed on the beamline.

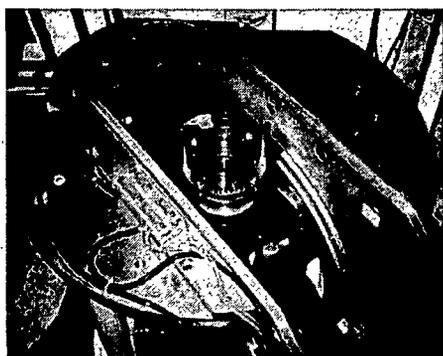


Figure 9 2-circle orienter

(left) Top view of the 2-circle orienter, with χ set to zero, in which orientation the ϕ axis is vertical. The Displex cooler is inserted in the centre. (right) This view shows the sample chamber with its vacuum port and also shows the encoder for the ϕ angles.

2. Performing an Experiment on SXD

2.1 Administration Requirements

All users must perform the following procedures before commencing their experiment:

- **Pre-register.** When allocated beamtime, users are requested to register the expected experimental team for the experiment. This should save time when arriving for the start of the experiment
- **If it is your first visit** to ISIS then you should visit the University Liaison Office (R3, Upper Ground floor, Room UG3 x5592, FAX 5103, email ULS@ISIS.RL.AC.UK). The ULO can also deal with accommodation and local transport arrangements and should always be the first point of contact on such matters.
- **Register** with the Main Control Room in R55 (x6789) to receive 'Permits to Work' and temporary film badges.
- **Security swipe cards** are necessary for access to the ISIS experimental areas. These will be issued by the Main Control Room on arrival.

2.2 Safety

The University Liaison Office will issue all users with a number of safety documents when they register as a new user. These must be read before beginning an experiment. There is also an ISIS Safety video, available at various points around the Facility, which new users must all view, and returning users must view at six monthly intervals. In addition, all those performing an experiment must ensure that they discuss with their local contact in advance the particular hazards on the SXD instrument and the approved procedure for performing the experiment.

All users are requested in advance to complete and return a 'Sample Record Sheet' (these are part of the ISIS Beam Time Application form). These forms are stored in a filing cabinet in the Data Acquisition Centre in R55 and the sample record sheet for the sample being run on the instrument should be displayed in the pocket by the interlock panel near the instrument for the duration of the experiment. The reverse of the form will contain comments (if any) from the ISIS Safety Section concerning possible chemical and radiological hazards associated with the sample. Any recommendations concerning the sample handling etc. must be followed and the form should be stored with any samples remaining at ISIS after the experiment. Irradiated samples should be stored in the SXD active samples cupboard which is located behind the eVS instrument cabin, downstairs from the SXD cabin.

When removing samples after irradiation the safety regulations concerning monitoring of induced β and γ activity and transferral of samples from cans must be followed. It should be noted that vanadium sample cans (and to a lesser extent aluminium) may become activated in the SXD beam (activated vanadium is a β emitter with a half life of $\sim\frac{1}{2}$ hour).

At the end of the experiment all samples which have been run on SXD must be monitored by the ISIS Health Physics Group (x6696) before being removed from the Experimental Hall.

2.3 Mounting a Sample

In most cases it is extremely advisable to discuss this aspect of the experiment with your Local Contact *well in advance* of the experiment, as poorly mounted or difficult to mount samples can cause unnecessary delays to your experiment.

For the most commonly used SXD sample environment, general guidelines for sample mounting are given below:

SE equipment	Distance to beam centre from fixed point	Ajustable	Type of pin
Ambient sample tank	320 mm from underside of inner top plate	yes ~5 cm	6 mm diameter pin
Cryostat	1271 mm from underside of top brass flange	yes ~2 cm	6 mm diameter pin
CCR orienter	276 mm from recessed underside of top flange	no	6 mm diameter pin
CCR (ω -rotation)	325 mm from underside of outer top flange	yes ~2 cm	6 mm diameter pin
Furnace	386 mm from underside of top flange	yes ~2 cm	4 mm male thread

Aluminium sample pins of 6mm diameter are available which include a taper to 1mm diameter, such that the minimum amount of material will be in the beam whilst still supporting the sample (Figure 10). For room and low temperature experiments, it is often most convenient to glue the samples directly to the pin using rapid setting Araldite. As much of the glue as possible should be masked by cadmium to reduce hydrogen scattering. It is important to allow the glue sufficient time to set (typically one hour) and not to jolt the sample on mounting into the apparatus. Samples for the furnace should be wired, or glued using high temperature cement onto a stainless steel or similar sample pin. For diffuse scattering experiments it is preferable, but not essential, to have an aligned sample, such that the reciprocal plane of interest scatters in the equatorial plane of the instrument. This makes analysis of the data more straightforward. Detailed operation of the sample environment equipment, e.g. use of exchange gas in the cryostat, is outside the scope of this manual and SE Group staff or the local contact should be consulted for instruction. There are also guidelines available in notices in the SXD instrument cabin.

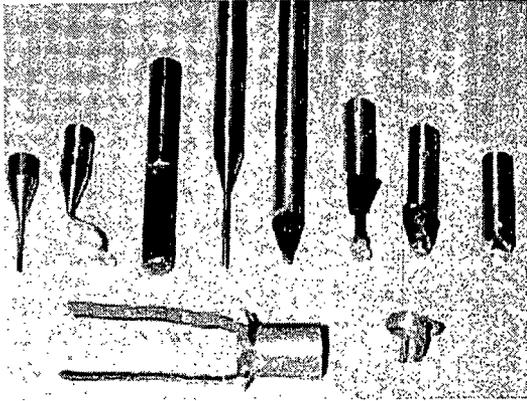


Figure 10 Sample mounting pins

SXD sample pins, showing some of the varied shapes and sizes these can take, as appropriate for a particular sample and sample environment. The longer pins tend to be appropriate for operation in the vacuum tank, while the shorter ones are required for Displex (Figure 11) and cryostat (Figure 12). Note that it is occasionally necessary to bend a pin in order to ensure the sample is centred in the beam. Also shown are some of the Cd masks used to avoid scatter from the pin material.

Figure 11 Displex cooler

This device allows for cooling of the sample to around 12 K, and is mounted into the 2-circle device. Most often used for structure determination work. (right) The sample is mounted into the copper block at the left hand side, with the pin held by a 1.5 mm hex-head set screw.

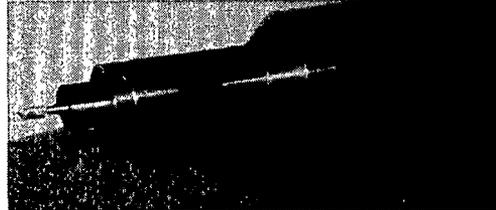
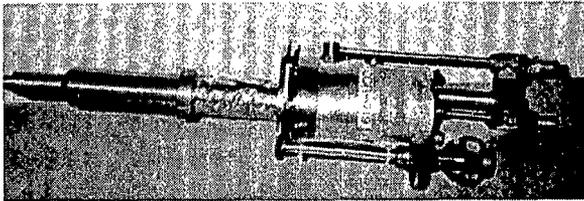
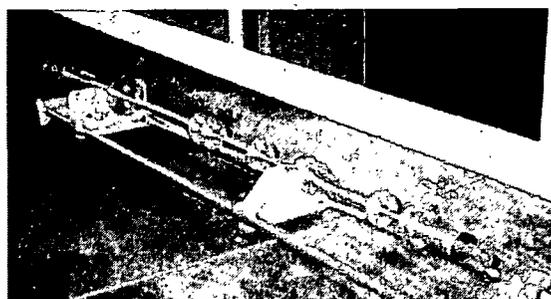


Figure 12 Cryostat centre stick

The sample is mounted into the copper block at the right hand side, with the sample centre at 1271 mm from the bottom of the large flange shown on the left of this picture. The height can be adjusted using the knurled knob above this flange (out of view).



2.4 Sample Tank Evacuation

Air scattering within the sample tank is reduced by evacuating the chamber before data collection. Having ensured that the vent valve on the top of the vacuum tank is closed, and that the collimation box lid is sealed, the pump is operated by pressing the furthest right square button on the pumping panel in the bottom of the right-hand electronics rack. To bring the vacuum up to room pressure simply turn off the pump and open the vent valve on the top of the vacuum tank. Clearly this section is **only** applicable to those experiments which use the sample tank. Attempting to operate the vacuum system without the sample tank will cause damage to the pump.

2.5 Installing Sample Environment equipment and instrument shielding

The sample environment equipment (cryostat, 2-circle orienter, furnace or vacuum tank) should always be located into the instrument by the instrument scientist, your Local Contact or ISIS technical staff. Once the apparatus is in position on the instrument and the sample is mounted on the centre stick, Displex, furnace insert or CCR, this should be carefully lowered into place (Figure 13). Only the most experienced users should attempt this alone - in most cases your Local Contact will assist or provide detailed instruction. Once the sample is in position and the SE equipment is set up, the instrument shielding should be completed inside the SXD sample 'cage' (Figure 14). Only once this has been done are you in a position to make the interlocks and prepare to open the shutter (section 2.6). Before completing the instrument shielding, the successful operation of any sample rotation devices, temperature sensors, vacuum systems etc should be checked and if necessary rectified at this stage. The shutter should only be opened once the experiment is properly set up.

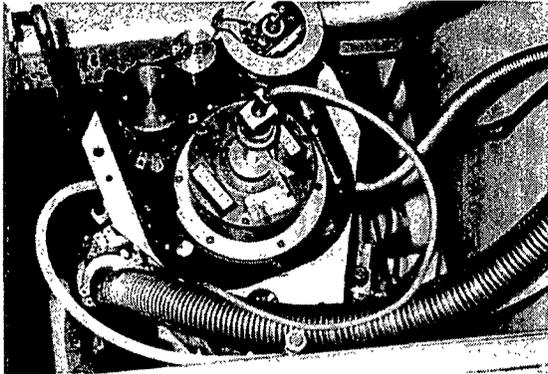


Figure 14 *Cryostat in place on the instrument*

The view shows the ω motor drive connections (centre top), the sample temperature sensor connector (centre), the He recovery (hidden behind the motor), the N₂ fill (on the left), the sample evacuation line (centre right) and, in this case, the Rootes pump vacuum line (lower left), for operation below 4.2 K.

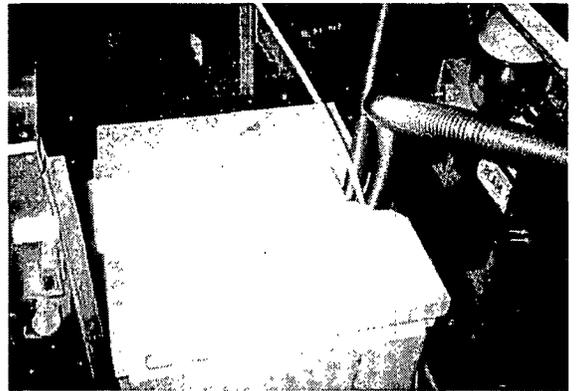
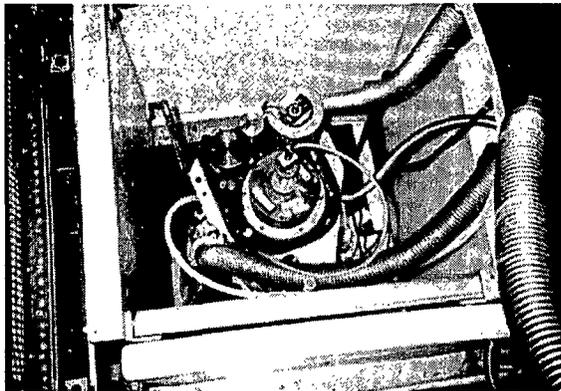


Figure 15 *Completing the instrument shielding*

Once all connections to the sample environment have been made (in this case to the orange cryostat and its centre stick), the borated polythene shielding around the top of the instrument, inside the sample access cage, must be completed. The pictures show the cryostat located within the shielding (left) and a typical rebuild of the remaining shielding to completely cover the sample space (right). A good rule of thumb is that the borated polythene slabs should be located such that the blue lights inside the blockhouse should not be readily visible from the top of the instrument. One of the half-sized polythene slabs has a square section cut from it to allow vacuum pipes, recovery lines etc to protrude conveniently.

2.6 Opening the Beam Shutter and the Interlock System

Before attempting to open the SXD beam shutter the interlocked area must be cleared of all personnel and then locked. If the lower door to the instrument has been opened, the interlocked area must be searched and the search button on the wall opposite the door must be pressed. This allows approximately 30 seconds to leave the interlocked area and close the lower door. It is then necessary to take the key (an 'S3-S' key) from the lock and insert it in a vacant position in the uppermost key rack, near the beam control panel next to the instrument. If the top hatch above the instrument has also been opened, it is necessary to cover this hatch with borated wax block shielding and close the interlocked gate. The key from this lock (also an 'S3-S' key) should then be inserted in a vacant position in the uppermost key rack.

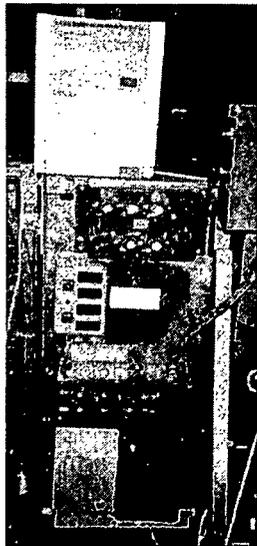


Figure 15 Shutter and interlocks

*Situated on top of SXD are the shutter interlock keys, the shutter status box (of which there is also one in the control cabin) and the sample record sheet holder, which **must** contain the record sheet pertaining to the sample in the beam.*

When all 'S3-S' keys are present in this rack the master 'S3-M' key may be removed and inserted in the green control box. The master key should be turned 90° so that it is vertical. The user should then check that the four red LEDs on the box below the beam control panel are lit, indicating that the interlocked doors are in the correct state and the emergency 'beam-off-buttons' have not been tripped. **Any attempt to open the shutter without all four LEDs being lit will immediately cause the ISIS accelerator to trip - an unpopular consequence!** If there are any difficulties with the interlock system, the user should immediately contact the local contact, an instrument scientist or the ISIS Main Control Room (x6789).

It is not possible to open the shutter unless the master key is correctly positioned in the green control box. The beam shutter is opened and closed by pressing the 'open' and 'close' buttons in one of the beam control units, which are sited near the instrument and in the SXD cabin. The shutter takes approximately one minute to open or close. When the shutter is open the master key cannot be removed from the green control box, the red 'beam on' lights are lit as are the blue warning lights in the interlocked areas to which there is no access.

If one finds oneself **inside** an interlocked area when the blue warning lights illuminate, the large **red** 'Beam Off' button should **immediately** be pressed and the ISIS MCR called (x6789) once the area has been evacuated.

2.7 Accessing the FEM

The SXD Front End Minicomputer (FEM) controls the instrument and its data acquisition, and the main terminal is situated in the instrument cabin. The colour workstation is used to control the instrument, run the dashboard, run the GENIE data display software and perform preliminary data analysis. These tasks are all possible simultaneously because it operates under Motif X-windows software (see below). Its nodename within the ISIS VAX cluster is SXD. Full instructions on the use of the features of the SXD workstation are outside the scope of this manual, and only a brief outline is given below.



Figure 16 Typical working view in the cabin

Note the multiple windows on the SXD workstation, the proximity of the carefully maintained instrument log book, the helpful instrument booklets and the ubiquitous cup of coffee. The Tipp-ex is never, of course, used to excise spurious data points!

2.8 The SXD workstation

Usually the SXD workstation is permanently logged on, with a current session in use. If for any reason this is not the case (e.g. the computer has crashed), a welcome message appears in the middle of the screen. To initiate a session on SXD, type SXD as the username, and the appropriate, current password (available from the instrument scientists). This will then start up a windows session, with a 'session manager' window, and possibly a

clock and other windows. In order to create more windows, press the left-hand mouse button (LHMB) on 'applications' in the 'session manager' to pop up the menu. Again with the LHMB, highlight the 'DECTerm' option. Releasing the LHMB on the 'DECTerm' option will (eventually) create a DECTerm window, which will automatically log in as a terminal session on SXD. When several window sessions are present, it is only possible for the user to be connected to any one window at a time. To move between windows, simply click the LHMB in the required window area. It is sometimes useful to reduce windows which are not in current use to icons. To do this, click the LHMB in the top-right square containing a small dot. This produces a small icon in the bottom right of the screen. To restore this window, either double click the LHMB when on this icon, or a single click with the LHMB will pop up a menu where the 'restore' option can be selected. Other operations can be deduced by trial and error, for example windows may be deleted, or changed in size, but it is not advisable to create too many windows (more than ~4) and many applications or alter the workstation settings. **Do not delete all of the windows, especially the one controlling the instrument** (see below).

2.9 The Dashboard

The instrument dashboard shows details of the current instrument setup and experimental run. The dashboard is usually displayed on the window which is in control of the instrument, the 'supervisor'. To see which window is the 'supervisor', type <CTRL>-T in the window and the timing details are displayed which also show the name of the process.

If the dashboard is not present it can be created by typing:

```
$ STATUS ON<return>          (can be abbreviated as STAT ON)
```

at the keyboard, having clicked the left-hand mouse button (LHMB) in the required window. To turn the display off type:

```
$ STATUS OFF<return>        (can be abbreviated as STAT OFF)
```

in the window showing the dashboard display. At the top of the display the current DAE state (RUNNING, SETUP, PAUSED etc.) and the run number are shown. The remaining information on the dashboard gives the run time, frame (proton pulse) count, present and accumulated proton beam, details of the incident beam monitor count and status of the CAMAC controlled apparatus (Figure 17).

SXD		is		RUNNING		RUN		5543	
RB Number 5099		Wed 11-May-1994 12:23:03		TEMP		LOGG		4.20	
User: S. Brown		Tel: x6556,5137		^-- raw -->				2.44	
Title: UPtAl3 RT w=30				TEMP1		LOGG		4.87	
Current run time		0 02:05:43		MONITOR		^-- raw -->		2.47	
Good/Raw frames		499894/499895		Spectrum		4097		OMEGA TRUE 30.00	
Current/Total uA		185.4/ 502.2		From(mms)		1000			
DAE memory used. Bytes		5403201		To(mms)		19900			
4100 Spectra		600 Channels		Counts =		5177044			

Figure 17 The SXD instrument control DASHBOARD

2.10 The DAE

The DAE (Data Acquisition Electronics) governs data collection for each individual run. Whilst a run is in progress the data are temporarily stored in the DAE and when it is completed the final data are automatically stored in a run called SXDnnnnn.RAW on the FEM (in area SXD\$DUA0:[SXDMGR.DATA], assigned the logical name **D:**). 'nnnnn' is a five figure run number which is automatically incremented at the end of each run. Shortly after creation, this file is also copied onto the archive system's optical disk. The current DAE mode and run status is displayed on the dashboard (see Figure 17). The possible modes of the DAE are:

- SETUP** Data are not currently being collected. The instrument parameters etc may be changed if necessary before starting a run.
- RUNNING** Data are currently being collected and being stored in the DAE
- PAUSED** Data collection temporarily suspended by the user (usually to allow temporary access to the interlocked areas).
- WAITING** Data collection temporarily suspended by the FEM. This may occur if CAMAC has run control set for SE blocks such as temperature which are outside their specified range.

2.11 Instrument Commands

Data collection is controlled by the Instrument Control Program (ICP). This program changes the state of data collection, either by user intervention, or because of flags obtained from the CAMAC sample environment control program. There are seven basic commands which change the state of the DAE. These commands must be typed at the 'supervisor' window/terminal (see section 2.9 to determine which window this is). They are listed below.

Command	Action
\$ BEGIN <return>	Sets DAE memory to zero Sets parameters in DAE to those specified by CRPT Instructs the DAE to start data acquisition Sets DAE state to RUNNING
\$ PAUSE <return>	Suspends data collection by DAE Sets DAE state to PAUSED
\$ RESUME <return>	Resumes data collection by DAE following a PAUSE Sets DAE state to RUNNING
\$ END <return>	Stops data collection by DAE Copies contents of DAE memory and CRPT to file 'SXDnnnnn.RAW' Increments the run number 'nnnnn' Sets DAE state to SETUP
\$ ABORT <return>	Stops data collection by DAE Data are NOT stored Sets DAE state to SETUP
\$ UPDATE <return>	Updates the DAE contents with most recent data DAE remains RUNNING
\$ STORE <return>	Copies contents of DAE memory and CRPT to file 'SXDnnnnn.SAV' DAE remains RUNNING

2.12 The CRPT and CHANGE Command

The Current Run Parameter Table (CRPT) file acts as an intermediate data storage file between the DAE and the final stored raw data file on the FEM. It also contains information on the instrument settings and configuration (the time channel widths, monitor spectrum etc.), plus some concerning the current experiment (sample title, users' names etc.). All this information is stored with the raw data in the SXDnnnnn.RAW file on the FEM at the end of the run.

It will usually be necessary to change some of the contents of the CRPT at the beginning of the experiment. This should be done in consultation with an instrument scientist or your Local Contact. The relevant command to type is

```
$ CHANGE/NOT <return>
```

at the 'supervisor' window, when the DAE is in SETUP mode. The /NOT(ABLES) parameter suppresses the loading of software tables which should remain unchanged and speeds up the CHANGE command. The screen then displays the first page of the current CRPT. The values in the various fields are altered using the DEFT screen editor, full details of which are in the PUNCH manual. Cursor keys move between fields and the keypad '.' key toggles between options. The most common fields to change are the time channel ranges and widths, or the title. To exit from the editor the user should press the <PF1> key followed by 'E' to overwrite the CRPT with the new values, or followed by 'Q' to leave the CRPT as it was prior to the editing session. Some simple alterations can be made without entering the DEFT editor, the most useful one being changing the title, i.e.

```
$ CHANGE TITLE BAF2_T=100K_w=123 <return>
```

or (to allow spaces and lower case letters)

```
$ CHANGE TITLE ""BaF2 T=100K w=123"" <return>
```

2.13 The CAMAC Environment and Useful Commands

For full details of the CAMAC system, users are directed towards the PUNCH user guide, although commands specifically useful for SXD operation are shown here. The dashboard shows the status of the current CAMAC controlled operations. Temperature and sample motions are controlled by the CAMAC crate, and each operation has a 'block' assigned to it, for example:

TEMP	Controls the temperature fed into the right hand eurotherm: the control temperature for the cryostat and CCRs; the sample temperature on the furnace
TEMP1	Controls the temperature fed into the left hand eurotherm: the control temperature for the furnace; the sample temperature for the cryostat and CCRs
OMEGA	ω -rotation on the sample tank and cryostat [$100^\circ < \omega < 400^\circ$]

OMEGAF	ω -rotation on the furnace [$0^\circ < \omega < 350^\circ$]
WCCR	ω -rotation on the CCR [$-159^\circ < \omega < 159^\circ$]
CHI	χ arc on the two circle orienter [$0.1^\circ < \chi < 90^\circ$]
PHI	ϕ arc on the two circle orienter [$0.1^\circ < \phi < 179.9^\circ$]

A block is changed by the CSET command, and information concerning the block is displayed by the CSHOW command:

```
$ CSET TEMP {/RANGE=n} {/(NO)CONTROL} nn
$ CSET OMEGAF nn {/WAIT}
$ CSHOW TEMP1/FULL
$ CSHOW PHI/ENQUIRE
```

Where those parts bracketed are optional qualifiers - see PUNCH manual.

2.14 An Example Command File for Control of the Instrument

During the running of an experiment, there are frequent changes to sample position, temperature etc. Therefore it is useful to be able to set up a series of commands which will be acted on in sequence by the instrument. This is done using a command file which is activated, in the 'supervisor' window by the command:

```
$ @SXD$DUA0:[SXD.SUBDIR]scan_file.COM
```

Care must be taken since often the 'supervisor' window is not in the same directory as the file.COM file, hence the explicit nature of the above command. The command file may be interrupted at any time using <Ctrl>-C or <Ctrl>-Y, but it should be remembered that if the command file is subsequently restarted, the commands which have already been acted upon by the instrument should be deleted from the start of the command file. The command file should **not** be interrupted during the operation of either BEGIN or END - this will cause the Instrument Control Program to hang.

The following command file was used to collect data on a defect fluorite crystal on SXD, at a range of temperatures and orientations. It shows the basic structure of a command file.

SCAN.COM for (Ca,Y)F_{2+x} hot experiment

```
$ cset temp1/control          ! Run control on TEMP activated
$!
$! T=250C
$!
$ cset max_power1 10         ! Limiting furnace power (%)
$ cset temp1/range=20 280    ! Only count when T=280±10, else WAITING
$ cset omegaf/wait 70       ! Rotate furnace ω n.b. always approach angle
$ cset omegaf/wait 78       ! from below
$ change title ""CaYF2.06 250C om=78""
$ begin
$ waitfor 500 uamps         ! Wait until ISIS has delivered 500 μamp.hr
$ end
$!
$ cset omegaf/wait 85
$ change title ""CaYF2.06 250C om=85""
$ begin
$ waitfor 500 uamps
$ end
$!
$! T=400C
$!
$ cset max_power1 20
$ cset temp1/range=20 430
$ cset omegaf 70
$ cset omegaf 78
$ change title ""CaYF2.06 430C om=78""
$ begin
$ waitfor 500 uamps
$ end
$!
$ cset omegaf 85
$ change title ""CaYF2.06 430C om=85""
$ begin
$ waitfor 500 uamps
$ end
```

2.15 The Setting Up of Non-absolutely Encoded Arcs

Certain arcs used on SXD are not absolutely encoded (currently WCCR and OMEGAF). In order to set them up (for example if the computer fails to read the resolver properly), it is necessary to re-initialise the resolver. To do this, the arc must be manually driven to its negative limit, by selecting the relevant motor position on the drive box RMI08 in the right hand electronics crate on top of the instrument, with the box set to local, and the direction set to '-'. When the negative limit has been reached, the red limit switch light on the box will go out. Care must be taken with this operation to ensure that He pressure lines etc. are not twisted excessively. The direction switch should then be set to '+', and the motor manually 'jogged' approximately 800 steps, or until the limit switch lights up again. At this point, all the zeros on the electronics box RDC03 should be pressed, and then the RMI08 box returned switched back to 'remote' such that the display goes out.

At the computer terminal, it is now necessary to run the command file

```
$ @CAMAC$DIR:SETUP_GONIOMETER
```

The user responds to the prompts, initially with the name of the arc in question, followed by a series of carriage returns to select the default values **until** two yes/no questions are asked, which should be answered in the affirmative. **Please do not change** the default values for the arc settings. This command file reloads the parameters necessary for the computer to convert the information received from the CAMAC crate, and resets the resolvers to zero (close to) the negative limit. It should now be possible to move the arc and receive a meaningful reading on the computer. If this is still the case, it may be necessary to reload the CAMAC software, which should be carried out as a last resort:

```
$ CSET CAMAC/STOP
```

```
$ CSET CAMAC/LOAD    ! This takes several minutes
```

```
$ CSET CAMAC/START   ! Spawns a subprocess which takes some time to initialise
```

It may also be necessary to subsequently reset the arc to the negative limit and repeat the above procedure. If any problems are encountered with this slightly 'fragile' procedure, your local contact or instrument scientist should be consulted.

2.16 The Archiver and Restoring Files

Data files are automatically archived soon after a run has been ENDED. To see which was the last file to be archived type:

```
$ TYPE SYS$PUBLIC:ARCHIVE.STATUS
```

The files are large and are therefore often deleted soon after the end of an experiment. In order to restore them for further data analysis, it is necessary to place them on the SCRATCH\$DISK, where they will only remain for one week.

A typical command for restoring files would be as follows:

```
$ RESTOD/CAT=SXD$DISK: [SXD MGR] CATALOGUE.941 -  
/OUT=SCRATCH$DISK: [SXD MGR] SXD05911.RAW -  
[SXD MGR.DATA] SXD05911.RAW
```

In order to see the status of the archiver, type either \$ MANOD/LIST=r or \$ MANOD/LIST. The first command gives a list of the files awaiting restoration, and the second gives the current status of the archiver. It should be noted that the archiver is occasionally temperamental, it is often necessary to be logged on to ISIS to be successful, and that it is necessary to know which catalogue file the required data file is stored under. For example CATALOGUE.941 refers to files from ISIS cycle 1/94. In order to see which files are contained in any one catalogue, type (for example):

```
$ LISTOD/CAT=SXD$DISK: [SXD MGR] CATALOGUE.941
```

Normally data files will be restored within 10 minutes. If however the data that is required is from some time ago, it may be stored on the offline archiver, in which case the files will not be restored until the following working day.

Periodically, the working subdirectories of SXD\$DUA0:[SXD] are archived by the instrument scientist under a local catalogue file. If these archived files are required, it is necessary to type the following:

```
$ SET DEF SXD$DUA0: [SXD.SUBDIR]  
$ DAVE_ARCHIVE_SETUP
```

and follow the instructions given.

3. Preliminary Data Assessment and Crystal Alignment

3.1 GENIE

GENIE is a data display and manipulation program which runs on ISIS and all the instrument FEMs. Full details of the commands available within GENIE are given in the GENIE manual and Appendix 2 of the PUNCH manual (available from the computer support office, Room 1.38 building R3). Only those commands which are directly relevant for preliminary assessment of the data will be described here and in subsequent sections.

To enter GENIE simply type in a window which is **not** the 'supervisor':

```
$ GENIE/SCALE=0.7 <return>
```

The window will display the GENIE header at the top of the screen, print some lines of text and then give the prompt >>. GENIE allows the user to inspect and manipulate the time-of-flight spectra from individual detector pixels, sum them together, convert from time-of-flight to d-spacing or Q etc. The data from run number 3018, for example, is accessed by typing:

```
>> ASSIGN 3018 <return>
```

When logged onto the FEM it is also possible to investigate the data currently being collected and stored in the DAE by replacing '3018' with 'DAE' in the above command.

3.2 Data Manipulation Within GENIE

Each individual pixel in the detector is related, in the data, to a spectrum number. The convention used on SXD is that, when viewing the face of the detector from the sample, the pixel in the lower right-hand corner is spectrum 1 (S1). The spectra then increase in number vertically up the right-hand side, before moving left into the next column (Figure 18). This means that the lower numbered spectra correspond to detector pixels at smaller 2θ .

Hence, for a square 4096 pixel detector, the spectra are numbered thus (looking from the sample position):

4096	---	-	-	--	128	64	
-	---	-	-	--	-	-	
-	---	-	-	--	-	-	
4065	---	2081	2017	--	-	33	←Equatorial plane of instrument
4064	---	2080	2016	--	-	32	
-	---	-	-	--	-	-	
-	---	-	-	--	-	-	
4033	---	-	-	--	65	1	
$2\theta_{\max}$		$2\theta_{\text{cen}}=\gamma$			$2\theta_{\min}$		

Figure 18 *Spectrum numbers on the detector*

Note that the second SXD detector has spectrum numbers offset by 4100 from these.

If one wishes to look at the raw data from the detector, for example, to check the crystal alignment, or if the plane to be examined is equatorial in the detector, then the simplest thing to do is to use some local utilities within GENIE. These are basically simple summations of strips up the detector, which are then plotted in 2θ steps using the MULTIPLOT command.

To sum from the DAE with a square detector (normal configuration) type:

```
>> @DP:SUMDAE lo hi npix                for detector 1 (high angles)
```

```
>> @DP:SUMDAE2 lo hi npix               for detector 2 (low angles)
```

where `lo` is the lowest row to be summed, `hi` is the highest and `npix` is the number of pixels on along the side of the detector (normally 64).

To sum from a previous run in the normal configuration type:

```
>> @DP:SUM lo hi npix run_no uamps      for detector 1 (high angles)
```

```
>> @DP:SUM2 lo hi npix run_no uamps     for detector 2 (low angles)
```

where `run_no` is the run number and `uamps` is the number of μamp -hours for which that run was collected. `DP:SUM` divides by `uamps`.

These commands put the data into GENIE workspaces W1 to W'npix' (normally W64) which can be plotted in the usual way using the MULTIPLOT command (see GENIE manual for full details). Often the choice of the parameters of the MULTIPLOT have to be carefully chosen in order to achieve a good looking and useful plot. Another useful command for inspecting an individual peak sums up a square surrounding a specified spectrum (spec_no):

```
>> @DP:CENTRE spec_no nsurr npix
```

where nsurr is the distance (in pixels) to radiate from spec_no (maximum of 4). For example 3 would add all spectra ± 3 pixels from spec_no, ie 49 spectra. This command places the summed data in workspace W10 (note that to use this command for detector 2, 4100 should be added to the spec_no).

The explicit commands for printing out hard copies from GENIE are (after plotting the required picture on the screen):

```
>> KEEP/HARD  
>> J "PRINT/QUE=POST$LSR3 DEC_POSTSCRIPT.DAT
```

This prints the picture on the laser printer in the LAD cabin in R55.

3.3 Identifying a Principal Reciprocal Lattice Row for Alignment

The first requirement for any experiment is to check the crystal quality and alignment. The former can be quickly assessed using the above MULTIPLOT procedure (and the rapid assessment of sample quality is a tremendous strength of SXD). The latter can be done either automatically using the autoindexing software (see Appendix on intensity extraction and structural refinement) or manually (especially in the case of aligned or high symmetry crystals). For the latter it is necessary to locate Bragg peaks which are scattering into the detector and which can be identified from their d -spacing. Clearly such reflections tend to occur at longer time-of-flight (larger d -spacing). Although peak searching routines are available, often the most straightforward method is to make use of the routines within GENIE described in the previous section. @DP:SUMDAE or SUMDAE2 can be used to collapse the whole detector area onto the 2θ axis, which can then be displayed using MULTIPLOT. This plot can then be inspected to locate reflections at long times-of-flight (which are the most likely to be unambiguously indexed), and the workspace which they occur in can be found (W'peak'). Displaying W'peak' individually will show (in the display header block) the spectrum number corresponding to the lowest spectrum in the vertical summation (S'min'). The MULTIPLOT command can then be used to display the individual spectra which were summed into this workspace,

and the spectrum which has the maximum intensity in the peak can be found (S'peak'). A suitable series of commands for a 64x64 detector would be:

```
>> @DP:SUMDAE 10 54 64          ! collapses data onto 2θ axis
>> MU W1>W64 1000 20000 4 1 10 ! displays collapsed data
>> MU W20>W40 1000 20000 4 1 10 ! displays collapsed data closer to W'peak'
>> D W'peak'                    ! identifies S'min' from header
>> MU S'min'>S'max' 1000 12000 ! displays contents of W'peak'
                                (S'max'=S'min'+44 in this case)
>> D S'peak'                    ! displays peak spectrum
>> D S'peak±64'                 ! checks those around S'peak'
>> D S'peak±1'                  ! checks those around S'peak'
```

The spectrum S'peak' in which the maximum intensity is found can then be used to determine the position of the peak on the detector face (see Figure 18).

$$j = \text{remainder of } (S'peak'/64)$$

$$i = \text{integer value of } (S'peak'/64)+1$$

j gives the height of the reflection in the detector and i is related to the 2θ value thus:

$$2\theta = \tan^{-1}\{[i-(ndet/2)]*pix/L_2\}+\gamma$$

'ndet' is the horizontal number of pixels in the detector and 'pix' is the size of the individual pixels (typically 3 mm). The following set of GENIE commands then convert the peak into *d*-spacing:

```
>> W1=S'peak'
>> SET PAR W1 'L1' 'L2' '2θ' 0 0
>> U/D W1
>> D W1
```

Having located and identified one reflection, others may be brought into the detector by suitable rotations of the sample, and the crystal alignment can be quickly determined. There are several utilities available for determining the crystal rotation angle between

given reflections, which can help this process. These routines are run outside GENIE by typing:

```
$ RUN DP:A          (for cubic systems)
$ RUN DP:AORTH     (for orthorhombic systems)
$ RUN DP:AHEX      (for hexagonal systems)
$ RUN DP:AMONO     (for monoclinic systems)
```

One of the strengths of SXD may readily be seen from a spectrum containing a principal lattice row: an individual spectrum in the SXD detector contains reflections in a Laue row, separated in time-of-flight (t-o-f, or λ , see section 4.1). Hence if, for example, the 113 reflection is observed at t-o-f₁₁₃, then the 226 is found at t-o-f₁₁₃/2 and the 339 at t-o-f₁₁₃/3 etc. all in the same pixel element.

3.4 Manual conversion of data to structure factor

It is sometimes useful to convert the raw data into an approximate structure factor within GENIE. The rigorous treatment of this is described in the Appendix on diffuse scattering data analysis - here we will outline an approximate set of routines.

```
>> ASS DAE          ! or the appropriate data run no.
>> @DP:CENTRE 'PEAK' NSURR NPIX ! peak is the spec. no. of the peak
>> W11=W10
>> ASS 'VRUN'      ! vanadium run number
>> @DP:CENTRE 'PEAK' NSURR NPIX
>> SET PAR W11 L1 L2 2TH 0 0    ! L2 and 2 $\theta$  calculated as before
>> FU W11 DP:SEARS_TOF W12     ! sample absorption correction
    .50          ! sample radius          ! (these parameters should be
    .0600        ! sample number density ! changed)
    6.00         ! sample scattering cross section
    5.00         ! sample absorption cross-section (@  $\lambda=1\text{\AA}$ )
>> W11=W11/W12
>> SET PAR W10 L1 L2 2TH 0 0
```

```

>> FU W10 DP:SEARS_TOF W12          ! V absorption correction
      .25          ! V rod radius          ! these parameters may
      .0722        ! V number density      ! change
      4.95         ! V scattering cross section
      2.83         ! V absorption cross-section (@λ=1Å)
>> W10=W10/W12
>> W11=W11/W10
>> U/LAM W11
>> FU W11 [SXD.CCW]LAM4 W12          ! reflectivity correction
>> D W12                               ! corrected data

```

These routines take the spectrum containing the peak(s) of interest and sum it up with neighbouring spectra to obtain an integrated intensity. This is then done for the identical spectra for a vanadium run. The vanadium run is then corrected for absorption, and the sample data are divided by the absorption corrected vanadium data. The data are then corrected for the λ^4 reflectivity, and the result is a pattern where the intensities of the peak(s) are proportional to $|F|^2$. No account is taken of the Lorentz factor ($1/\sin^2\theta$), but this is a constant within a single Laue row, and no account is taken of the extinction. It should also be noted that if the peaks are extremely sharp it is not always precise enough to sum the data and divide by the summed vanadium, it may be necessary to divide the data by vanadium pixel by pixel, since the detector response is not uniformly smooth.

3.5 Producing a Laue Plot of the Data

To produce a Laue plot of the data, it is necessary to integrate the whole time-of-flight range for each pixel, and then plot out the result. To do this, in the 'supervisor' window type:

```

$ UPDATE
$ SUM

```

which produces a file called SUMSPEC.ANS from the dae (the current run). This file can be plotted by running the program DP:PLOT3D_SUMSPEC. If you want to inspect a previous file (in which case this process is lengthy) the commands are:

```

$ EXP          ! to expand the RAW data file (delete the expanded file after use)
$ SUM          ! the filename (SXD'nnnnn'.EXPAN) must be typed in explicitly

```

4. Introduction to data collection and reduction procedures

As with most modern automated diffractometers, the aim of SXD when it is used as an instrument for standard structure determination and refinement is to produce a set of structure factors for use in refinement, with the minimum possible manual intervention. To enable this, a semi-automatic data reduction procedure has been written which is described in a separate document. The local contact will assist in use of this procedure and in routine cases the user will be provided with a set of observations in the form of $[h,k,l,F^2, \sigma(F^2)]$.

The basic method of data collection using a time-of-flight Laue diffractometer is substantially different from standard four-circle methods and is summarised below. For more detail please refer to the separate Appendices.

4.1 Time-of-flight Laue diffraction

The time-of-flight Laue diffraction (tofLD) technique exploits the capability of a single crystal diffractometer on a pulsed neutron source to access large volumes of reciprocal space in a single measurement. This is due to the combination of the wavelength-sorting inherent in the time-of-flight (tof) technique with large area position-sensitive detectors (PSDs). The tof technique exploits the fact that the neutrons produced at an accelerator-based pulsed neutron source are created at a known time, t_0 , the time at which the high energy particle beam hits the neutron-producing target. Subsequently, as a consequence of the massive nature of the neutron, the velocity of each neutron is related to its wavelength. By recording the arrival time, t , of each neutron at the detector, a known distance from the source, it is therefore possible to calculate its time-of-flight, $t-t_0$, its velocity and hence its wavelength. Since typical times-of-flight are of the order of milliseconds at ISIS (pulse frequency 50 Hz, leading to a repeat period between pulses of 20 ms), it is relatively straightforward to produce the required timing electronics, allowing each detected neutron to be uniquely flagged with its wavelength.

Single crystal diffraction using a white beam with a stationary crystal and a white beam is the Laue method. The variant described here, tofLD, provides a wavelength-sorted version of this. tofLD thus gives a genuine sampling of three dimensions of reciprocal space in a single measurement.

4.2 Bragg data collection and reduction in time-of-flight Laue diffraction

The large volume of reciprocal space observed in a single measurement, sorted in both time and space, is termed a histogram or frame in tofLD. Collection of a complete structure factor set in this diffraction geometry consists of the accumulation of a series of such frames, each collected with a stationary crystal and detector arrangement.

The crystal is typically mounted on the two-circle orienter (χ, ϕ) in a Displex closed cycle refrigerator (CCR) helium cryostat. The computer-controlled temperature in this device is

measured by a Rh-Fe thermocouple sited around 10 mm from the sample at the CCR head.

In a typical experiment, two PSDs, each of $192 \times 192 \text{ mm}^2$ active area, in $3 \text{ mm} \times 3 \text{ mm}$ pixels, are used. These are typically situated with their centres at $2\theta \sim 55^\circ$, $L_2 \sim 190 \text{ mm}$ from the sample (low angle detector), and $2\theta \sim 125^\circ$, $L_2 \sim 160 \text{ mm}$ from the sample (high angle detector). There is thus a very large angle subtended at the sample by both detectors.

Data are collected in a series of frames (normally between 15 and 46) from each detector, at a series of (χ, ϕ) angles to give good coverage of reciprocal space. A typical wavelength range is $0.5\text{-}5 \text{ \AA}$. The nature of the data collection is such that different $\sin\theta/\lambda$ values are reached in different parts of the detector. Typical frame exposure times are around 1-6 hours, depending on unit cell and crystal size, resulting in several hundred observed reflections in each detector. This data collection method, and the large degree of overlap between frames collected at different times, leads to a large over-determination of equivalent reflections in the data set. The normalisation and merging procedure can then be used to check if there is any measurable change in the diffracting power of the crystal during the data collection.

With many reflections determined within each frame, this allows straightforward determination and refinement of the UB matrix. Each three dimensional data histogram is searched for peaks and these are indexed using the UB matrix. The cell dimensions are determined using a refinement of the UB matrix with respect to a set of reflections taken from a wide range of data frames, thus ensuring good averaging. For peak integration, on the other hand, the local UB refined for the particular frame under consideration is used. After refinement of the local UB, peak integration can be undertaken in one of two ways, using either the peak positions predicted from the UB or those found in the peak searching. The latter approach is usually adopted at present.

The peaks are integrated using a profile fitting approach based on the known analytical shape of the reflections in the time-of-flight direction, well understood from the characteristics of the ISIS source and moderator. Box and ellipsoid fitting, based on $\sigma(I)/I$ methods, are also available but are found to be less reliable in the current set-up. The function used in the profile method is a Gaussian convoluted with a decaying exponential function, which is found to reproduce the peak shape well. The variable parameters in this fit are the Gaussian height and width and the time constant of the exponential, all of which vary with time-of-flight. This method is found to be both sensitive and reliable in the integration of both strong and weak peaks. It should be noted that reflections for which this profile fitting procedure fails after four attempts on different integration windows are excluded from the data set, thus resulting in a somewhat reduced occurrence of very weak or "unobserved" peaks in the final data set.

The reflection intensities extracted using these standard SXD procedures are normalised to the incident beam profile using the incoherent scattering from a polycrystalline vanadium sample. Semi-empirical absorption corrections are also applied at this stage, using the vanadium and sample scattering. The resulting intensities are reduced to structure factors, giving data sets of reflections from the high and low angle detectors

respectively. These data are then used in the CCSL (Brown & Matthewman, 1993) least squares refinement program SFLSQ, to apply a variable wavelength extinction correction based on the Becker-Coppens formalism (Becker & Coppens, 1974a,b), normally using a Gaussian model with one variable parameter, the mosaic spread.

The resulting corrected structure factors are then merged and subject to initial refinements in the GSAS program (Larsen & von Dreele, 1986) before final refinement proceeds in GSAS, CCSL, SHELX or any other structure refinement program, since by this stage the data comprise a fully corrected structure factor set which can be used in standard refinements. It should be noted that the very large over-determination of SXD Laue data sets, the use of PSDs to collect the data and the complex wavelength-dependent corrections which have to be applied, tends to lead to rather higher merging R-factors and hence higher crystallographic R-factors, than is normally found with constant wavelength data. Nonetheless, conventional crystallographic R factors (R(F)) of around 6-8% are normally obtained on SXD, which are perfectly acceptable.

References

Wilson, C.C. (1990) in "Neutron Scattering Data Analysis 1990", ed M.W.Johnson, pp 145-163, IoP Conference Series vol 107, Adam Hilger, Bristol.

Brown, P.J. & Matthewman, J.C. (1993). Rutherford Appleton Laboratory Report, RAL-93-009.

Becker, P. & Coppens, P. (1974). Acta Cryst A30, 129 and 148.

Larsen, A.C. & von Dreele, R.B. (1986). GSAS. Los Alamos National Laboratory Report, LAUR 86-748.

4.3 Introduction to diffuse scattering data collection and reduction procedures

SXD frames are collected with a fixed sample, fixed detector geometry, with the detectors arranged to maximise the measured volume of reciprocal space without compromising resolution or background. The principle for diffuse scattering data collection therefore is to orient the sample and detectors to minimise the number of sample rotations required to measure all the regions of reciprocal space of interest. It should be emphasised that SXD is a surveying instrument and as such it is more suited to measurements which require determination of large regions containing diffuse scattering rather than investigations of one (smaller) diffuse feature. Typically the sample would be aligned with the principal features of interest scattering into the equatorial plane of the instrument and the unique portion of this reciprocal lattice plane would be mapped out completely. Very high- Q features can be measured. It must however be remembered that SXD is a largely uncollimated instrument. This has the effect of reducing the dynamic range and may be important when looking for inherently weak signals. This is not to say that the instrument has a high background (it is extremely small for an instrument of its type - 10^4 - 10^5 signal to noise is easily possible), but that other scattering from the sample may obscure the features of interest. For example the instrument resolution may broaden strong thermal

diffuse scattering thus masking other features. Perfect sample alignment is not required and the data reduction software allows the correction of data which are not in the equatorial plane.

A typical experimental schedule would be as follows:

1. Mount the sample and check orientation and sample quality;
2. Optimise detector positions and shielding for the measurement;
3. Measure the number of frames required to map out the required portion of reciprocal space. It is usual to use ω -rotation only for this - the χ - ϕ orienter has too high a background for careful diffuse scattering measurements. Counting times are critically dependent on the strength of the signal and may be between 2 and 12 hours per frame.
4. Repeat 3. for the required number of temperatures etc.
5. Remove sample and run a background without disturbing detectors or sample environment. The time for this run will depend on the strength of the background - if it is a significant part of the scattering it should be run for as long as the sample frames were run for but if it is small then less time can be used.
6. Run a vanadium rod, either in the same sample environment (and use the background in 5. for subtraction) or in the vacuum tank, again without moving the detectors. This should ideally be an overnight run.

The data correction procedure is different from that used to determine Bragg intensities. This is because the data are used to determine the differential scattering cross-section rather than the total (elastic) scattering for each Bragg reflection. The data correction, which is described in detail in one of the Appendices, is much more akin to that used to produce liquid or amorphous structure factors. In outline, the data and vanadium are measured in identical conditions and, once background scattering has been subtracted, the vanadium spectra are used to normalise the sample spectra. The vanadium scattering takes into account the relative efficiencies of different pixels (spectra) on the detector, the incident neutron flux profile and the detector response at different neutron energies. The software can take in to account the effects of absorption, multiple scattering and inelasticity, although it is most appropriate for equatorial scattering where the cylindrical geometry approximations are least severe. The refined UB matrix is used to define which (x,z,t) points should be included in the (q_h, q_k, q_l) points in the reciprocal lattice plane of interest. Further details can be found in the relevant Appendix.

5. Summary

The information given here should allow an SXD experiment to be started successfully, the diffraction from a crystal to be checked and in favourable cases, the crystal alignment to be found. The running experiment can generally now be left in the capable hands of the instrument computer, executing some command procedure that has been prepared for the changes and controls in the experiment. The data accumulation now under control, refer to the accompanying Appendices for details of data reduction and analysis.

6. Appendix - Useful Information

6.1 Useful Telephone Numbers

	RAL Extension	Bleep/Mobile Number	email
Dave Keen	6556		DAVEKEEN
Chick Wilson	5137	203	CCW
Kevin Knight	5220		KSK
Steve Hull	6628		SH
Jimmy Chauhan	6182	3252 (mobile)	
S. E. Lab.	5721		
Main Control Room (MCR)	6789		
Health Physics	6696		
RAL Main Gate/Security	5545		
Computing Support	5414	3029 (mobile)	SUPPORT
University Liaison Office	5592		ULS

To dial an office extension from outside RAL dial (01235) 44+extn. To make an external call from a RAL phone dial 9 before the number. To bleep somebody, dial 70 followed by the bleep number followed by the extension number you are dialling from. Wait for the tone before replacing the receiver.

6.2 Eating and Drinking

6.2.1 RAL Opening Hours

R22 Restaurant	Mon-Fri	Sat-Sun	
Breakfast	7.00-8.00	8.00-9.00	
Lunch	11.45-13.45	12.00-13.00	
Dinner	17.00-19.00	18.00-19.00	
R1 coffee lounge (hot drinks and snacks)	9.30-11.30	(Mon-Fri)	
	12.30-15.30	"	
R22 coffee lounge	12.45-13.45	"	

6.2.2 Pubs

Abingdon	<i>King's Head & Bell</i> <i>Old Anchor</i> <i>Brewery Tap</i>	Historic. Good position on Thames. Their Morland's should be good and is!.
Aldworth	<i>The Bell</i>	CAMRA pub of year, excellent beer and massive crusty rolls. In Good Pub Guide.
Blewbury	<i>The Red Lion</i>	Compact & atmospheric. In GPG.
Chilton	<i>Rose & Crown</i>	Basic but close to the Lab.
East Hendred	<i>The Plough</i> <i>Wheatsheaf</i>	Good food, mediaeval feel. A favourite, good beer & food. In GPG.
East Ilsley	<i>The Crown & Horns</i> <i>The Swan</i>	Terrifically atmospheric, race-horse theme, interesting food. In GPG. Tidy enough.
Oxford	plenty of choice....	Note especially the <i>Turf Tavern</i> , <i>King's Arms</i> , <i>Eagle and Child</i> , <i>Lamb & Flag</i> , <i>Wheatsheaf</i> , <i>Chequers</i> , <i>Bear</i> , (all in Town Centre) and <i>Victoria Arms</i> (on the River Cherwell).
Steventon	<i>The Cherry Tree</i>	Interesting double roomed pub with good beer & food. In GPG.
Wantage	<i>The Lamb</i>	Dark and low-beamed, specialises in good food.
West Hendred	<i>The Hare</i>	On main road, interesting building and decent sandwiches.
West Ilsley	<i>The Harrow</i>	Magnificent position, opposite cricket pitch and downs, pies a speciality. In GPG.